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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/881,129	TONOUCHI, TOSHIO	
Examiner	Art Unit	
Ajay M. Bhatia	2145	

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
See east search for classification and text search	11/14/2005	АВ	
Inspec search	11/14/2005	ΑB	
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